

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/521,848 VAN DER VEEN ET AL.	
		Examiner	Art Unit DARREN SCHWARTZ	2435 Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0054149 A1	12-2001	Kawaguchi et al.	713/175
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

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